

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10811498	DUHAMEL ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
	Lee, Benjamin W	3714

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
463	16,20,22,25,30,31	1-4-2007	BWL
273	143R	1-4-2007	BWL
	updated	07/20/2007	BWL

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Inventor Name Search	1-3-2007	BWL
Assignee Search	1-3-2007	BWL
Consulted with Kim Nguyen, Cls. 463, 273	1-3-2007	BWL
PLUS Search	12-5-2006	BWL
East Text Search (See attached "Search History")	1-5-2007	BWL
Backwards/Forwards Search	1-5-2007	BWL
EAST Text Search (see attached "Search History")	07/20/2007	BWL
Updated Search	03/14/2008	BWL
EAST Text Search (see attached "Search History")	03/14/2008	BWL
see attached	9/26/08	mas

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>